## Applicant(s)/Patent Under Application/Control No. Reexamination 10/077,510 XU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2664 Venkatesh Haliyur **U.S. PATENT DOCUMENTS** Date **Document Number** Name Classification Country Code-Number-Kind Code MM-YYYY 370/389 11-2004 Schuster et al. US-6,822,957 Α 03-2002 Falck et al. 709/227 US-6,360,265 В 709/224 08-2002 US-2002/0103898 Moyer et al. C Phomsopha, Bounthavivone K. 370/389 D US-2003/0048780 03-2003 370/401 05-2004 Borella et al. E US-6,731,642 370/389 US-2003/0016664 01-2003 MeLampy et al. F G US-USн US-1 USj Κ US-US-L US-M FOREIGN PATENT DOCUMENTS Date **Document Number** Country Name Classification MM-YYYY Country Code-Number-Kind Code N O P Q R S Т NON-PATENT DOCUMENTS Include as applicable: Author, Title Qate, Publisher, Edition or Volume, Pertinent Pages) U ٧ W \*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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